Localized microwave resonances in strained SrTiO₃ thin films

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Local frequency-dependent polar dynamics of strained $SrTiO_3$ films grown on $DyScO_3$ are investigated using time-resolved confocal scanning optical microscopy. Spectroscopic information is obtained with < 1 m spatial resolution over the frequency range 2-4 GHz. Most of the $DyScO_3$ film is found to be spatially homogeneous, in contrast to relaxed films. A strong correlation between spatial and spectral homogeneity is revealed. In addition, resonant structures are discovered that are localized both in space and in frequency.

Understanding the relationship between the polar structure and dynamic response of ferroelectrics is critical for the development of integrated devices. There are many factors which can produce dielectric dispersion in these systems. Some are intrinsic to the phase transition itself, while others depend on the existence of domain structures and their dispersive properties. Arlt et al. have predicted that stripe domain patterns in bulk BaTiO₃ single crystals will produce strong dispersion in the GHz regime [1]. Similarly, polar complexes observed in relaxor ferroelectrics have been identified by their characteristic frequency response [2, 3]. McNeal and coworkers have linked the domain state of BaTiO₃ (by way of grain and particle size) with microwave resonances [4]. The relevant length scales for ferroelectrics span an unusually wide range, from the atomic [5] to the crystal dimension itself [6], and frequency responses can also span from quasi-dc (~ 1 Hz) [7] to the ferroelectric soft mode (~ 10^{11} Hz) [8, 9]. Understanding how polar structure at a given length scale relates to the dynamic response at a given frequency scale can shed light on basic issues for device fabrication such as the fundamental limitations for domain switching and mechanisms of microwave dielectric loss.

The dielectric constant of capacitors fabricated from ferroelectric thin films can be changed with modest applied DC voltages, making them suitable for tunable microwave devices such as phase shifters [10] and filters [11]. A widely investigated material system is Ba_xSr_{1-x}TiO₃, whose Curie temperature T_c can be varied from nearly 0 K for pure SrTiO₃ (x = 0) to 400 K for pure BaTiO₃ (x = 1) [12]. For thin films grown under most conditions, non-uniform strain as well as stoichiometry fluctuations can lead to an inhomogeneous broadening of T_c over hundreds of degrees. The growth of highquality ferroelectric films is complicated by a lack of suitably lattice matched substrates. Recently, bulk single crystals of DyScO₃ have been synthesized and used to grow uniformly strained SrTiO₃ films by molecular beam epitaxy [13, 14]. The large biaxial tensile strain in this system results in ferroelectric behavior at room temperature [14, 15].

Here we describe local spectroscopic investigations of polar dynamics in a 500 \ddot{i}_{ℓ} thick SrTiO₃ film grown on DyScO₃ [14], We have developed an extension of time-resolved confocal scanning optical microscopy (TRCSOM) that enables lo-

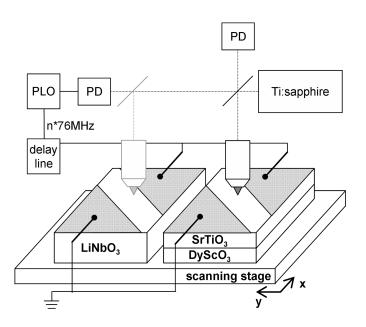


Figure 1. Diagram of experiment. Pulses from a mode-locked Ti:sapphire laser are sampled by a fast photodiode (PD) that provides a reference for a microwave-frequency phase-locked oscillator (PLO) whose frequency is locked to a high harmonic of the fundamental repetition rate ($f_1 = 76$ MHz) of the laser. This microwave signal is then applied to the sample by using interdigitated silver electrodes. The microwave signal at the sample is delayed in time relative to the incoming laser pulses using a programmable delay line. The samples are raster scanned relative to the microscope objective with a piezoelectric stage to produce images. A single-crystal LiNbO₃ sample is used to produce a reference phase at the different frequencies.

cal polar dynamics to be measured as a function of frequency as well as spatial location. Using the electro-optic response to reveal polar dynamics in the $SrTiO_3$ film, we identify localized resonant features associated with the periodic domain boundaries. While the domain structure appears to be templated by the DyScO₃ substrate, the existence of these resonant features represent the first direct experimental evidence linking microwave resonances to domain structures.

A schematic of the experiment is shown in Figure 1. An ultrafast (~ 120 fs) mode-locked Ti:sapphire laser is used to generate both the microwave electrical "pump" field and the

optical probe pulse. The microwave pump signal is derived from a phase-locked oscillator (PLO) that is locked to a high harmonic of the repetition rate of the laser, $f_1 = 76$ MHz. The electrical signal is applied to the SrTiO₃ film using Ag interdigitated electrodes deposited on the film surface (gap width $d = 10 \,\mu\text{m}$), and are oriented parallel to the <100> STO direction. Details about sample preparation can be found elsewhere [13, 14]. The laser pulses, focused to a diffraction-limited spot using a microscope objective (NA = 0.85), probe the electrooptic response at a fixed phase of the microwave signal. The relative phase between electrical and optical signals is controlled using an electrical delay line. The amplitude of the microwave field is modulated at a low frequency (~ 1 kHz) and the resulting electrooptic signal is detected using an optical bridge and lock-in amplifier [16]. The reflected polarization of the laser light probes the electrooptic response. The temporal response provides direct information about local polar contributions to the microwave permittivity of the film [17].

TRCSOM images are acquired by raster scanning the sample relative to the laser spot. Images are taken at ten different time delays td (step size $\delta t = 50$ ps) for 27 different microwave frequencies $f_n = nf_1$, $26 \le n \le 53$, spanning the range 2-4 GHz. An entire scan of frequencies, time delays, and spatial locations takes approximately 12 hours to complete; thermal control of the TRCSOM apparatus is maintained to within $T \sim 0.02$ K in order to stabilize the images sufficiently. The experiment is preformed at room temperature (295 K), which is above T_c in this sample. Post-processing of the images is also performed to account for residual drift over the acquisition period.

There is no intrinsic method for defining the absolute phase of the incident microwave field relative to the optical probe, and the measured phase changes in an uncontrolled way from one microwave frequency to another. To produce a stable reference phase, TRCSOM measurements were taken under identical conditions are taken on a single-crystal LiNbO₃ reference sample, located several mm away from and connected in parallel with the SrTiO₃ film. The phase of the linear electro-optic response of the LiNbO₃, assumed to be constant over the frequency range explored, is used to define a reference phase for the frequency-dependent SrTiO₃ measurements.

The polar response of the SrTiO₃ film is well described by Fourier components at angular driving frequency $\omega_n = 2\pi f_n$ and second harmonic $2\omega_n$ [18]:

$$S(t) = S_0 + F_1 \cos(\omega_n t) + F_2 \sin(\omega_n t) + P_1 \cos(2\omega_n t) + P_2 \sin(2\omega_n t)$$

At each driving frequency, the sequence of images at various time delays is used to produce a fit to Eq. 1 at each spatial location. The result is an image of each of the four Fourier coefficients, $\{F_1, F_2, P_1, P_2\}$. This analysis is performed for each of the 27 discrete frequencies investigated.

Figure 2 shows images of the phase at six representative driving frequencies. The large uniform regions visible in Fig-

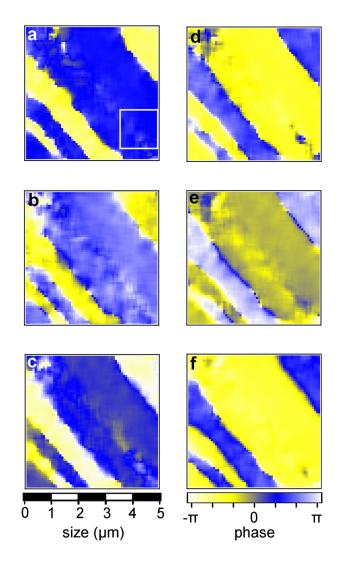


Figure 2. (Color online) Phase of ferroelectric response ϕ plotted as a function of location in the sample for six microwave driving frequencies. (a) 2.2 GHz, (b) 2.43 GHz, (c) 2.74 GHz, (d) 2.96 GHz, (e) 3.27 GHz, (f) 3.5 GHz.

ure 2 are characteristic of the high quality of the SrTiO₃ film, and are observed only with uniformly strained samples grown on DyScO₃ substrates [14]. The stripes correspond to regions that are responding uniformly over the entire frequency range investigated. Alternating stripes differ in phase by approximately π , which is consistent with the existence of a domain wall boundary separating them. These domain boundary regions exhibit a microwave response that is much less uniform, and which exhibit dispersive behavior that is localized in space and in frequency.

To illustrate the ferroelectric response within domains and near the domain walls, we analyze subsections from the datasets shown in the boxed region in Figure 2(a). Figure 3 shows vector field plots of the linear electro-optic response at two microwave frequencies and two different dc bias voltages. Arrows are colored according to the magnitude of the

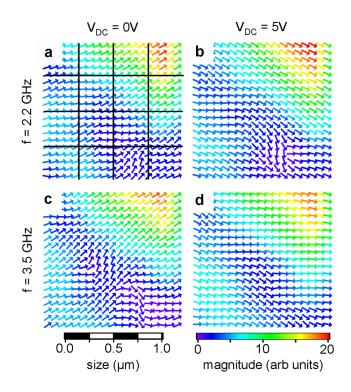


Figure 3. (color online) Vector plots showing magnitude (color) and phase (angle) in the region identified in Fig. 2 (a). (a) and (b) compare DC biases of 0 V and 5 V, respectively, at 2.2 GHz. (c) and (d) compare DC biases at 3.5 GHz

response, while their direction indicates the local phase relative to the LiNbO₃ single crystal. Regions of the sample that are far from the domain boundaries have a uniform response, irrespective of applied frequency or DC bias. However, select regions that are closer to the domain boundaries show significant local dispersion when a DC bias is applied.

To further investigate the local dynamics, the complex electro-optic response $\mathbf{F} = F_1 + iF_2$ is compared for several regions of the sample. In Figure 4, the linear electro-optic response for the 16 sub-regions identified in Figure 3 are averaged and plotted as a function of applied electric field frequency. Highly dispersive responses are observed at 2.4 GHz and 3.5 GHz. When a DC bias is applied, the dispersion increases at 2.4 GHz while decreasing somewhat at 3.5 GHz.

A typical characteristic of relaxor ferroelectrics is their dielectric dispersion characteristics, many of which can be understood by sound emission due to domain walls vibration [19]. Biegalski *et al* have shown that these SrTiO₃/DyScO₃ films show relaxor behavior in this frequency range [20]. Additionally, the periodic domain structures observed by TRC-SOM may produce shear waves that interfere constructively or destructively, depending on the driving frequency [1]. In addition to providing evidence of uniform ferroelectric response, the stripe domain pattern we observe could also be the source of the resonances we detect near the domain boundaries and within the domains themselves.

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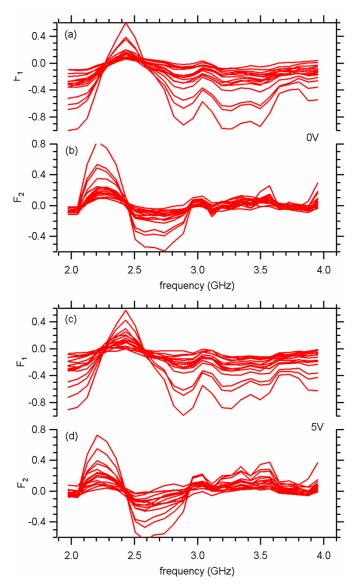


Figure 4. In- and out-of-phase components of ferroelectric response plotted as a function of driving field frequency. Curves are taken from the area shown in Fig. 3 and each line is an average over each of the 16 sub-regions identified in Fig. 3(a).

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